## TIPP 2011 - 2nd International Conference on Technology and Instrumentation in Particle Physics



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## Beam Profile Monitor Instrumentation in the Fermilab M-Test Beam

Friday, 10 June 2011 16:00 (20 minutes)

The profile monitor instrumentation for the M Test beam includes a suite of types each suited for a range of beam fluxes and energies. The types of detectors and the description of the characteristics of each will be discussed including experimental types using scintillating plastic fibers for ultra-low fluxes.

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